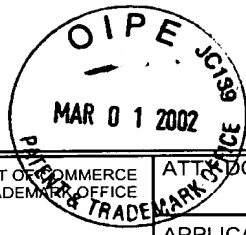




SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		PRIORITY DOCKET NO. 215551US2		SERIAL NO. 09/986,277	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hideki TAKAHASHI			
				FILING DATE November 8, 2001		GROUP 2811	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
ML	AO	8-222728	08/30/96	JAPAN (with English Abstract)			X
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner					Date Considered 9/4/02		
*Examiner. Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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SERIAL NO.

09/986,277

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hideki TAKAHASHI

FILING DATE

November 8, 2001

GROUP

2811

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
MC	AA	5,894,149	04/13/99	A. UENISHI, et al.			
MC	AB	6,111,290	08/29/2000	A. UENISHI, et al.			
MC	AC	6,218,217	04/17/2001	A. UENISHI, et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
MC	AO	9-331063	12/22/97	JAPAN (submitting corr. US 5,894,149, US 6,111,290 and 6,218,217 only)		
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	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

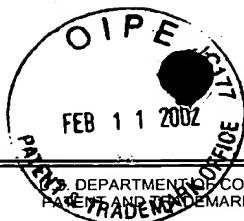
	AW	
	AX	
	AY	
	AZ	

Examiner

Date Considered

9/4/02

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Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

215551US2

SERIAL NO.

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LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hideki TAKAHASHI

FILING DATE

November 8, 2001

GROUP

2811

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
ML	AA	6,107,650	08/22/2000	H. TAKAHASHI, et al.			
	AB	5,864,159	01/26/99	H. TAKAHASHI			
	AC	5,751,024	05/12/98	H. TAKAHASHI			
	AD	5,801,408	09/01/98	H. TAKAHASHI			
	AE	5,981,981	11/09/99	H. TAKAHASHI			
	AF	6,118,150	09/12/2000	H. TAKAHASHI			
	AG	6,040,599	03/21/2000	H. TAKAHASHI			
	AH	6,198,130	03/06/2001	S. NOBUTO, et al.			
	AI	6,008,518	12/28/99	H. TAKAHASHI			
	AJ	6,221,721	04/24/2001	H. TAKAHASHI			
	AK	6,331,466	12/18/2001	H. TAKAHASHI, et al.			
ML	AL	6,323,508	11/27/2001	H. TAKAHASHI, et al.			
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
ML	AO	8-316479	11/29/96	JAPAN (with corr. US 6,040,599)		X
ML	AP	9-331063	12/22/97	JAPAN (with English Extract)		X
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

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